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Sheet <u>1</u> of <u>1</u>

INFO	RMATI	Form PTO-1449 US Dept. of Commerce (REV. 8-83) PATENT & TRADEMARK OFFICE			ATTY DOCKET NO. 126363			APPLICATION NO. New U.S. National Stage of PGT/JP2004/0072528 6 5		
INFORMATION DISCLOSURE STATEMENT								790	1869	
(Use several sheets if necessary)				APPLICANTS Nobuaki MITAMURA et al.						
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R/H	1	JP A 11-147786 w/ abst & transl	6/2/1999		JAPAN					
Fit.	2	JP A 2000-178099 w/ abst & transl	6/27/2000		JAPAN					
TVITO	3	JP A 2002-201093 w/ abst & transl	7/16	5/2002	JAPAN	,				
	l	OTHER DOCUMENTS (In	cludin	~ Author 7	Cialo Data Box	Danna				
БН.	4	OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) VORONKOV, "The Mechanism of Swirl Defects Formation in Silicon," Journal of Crystal Growth, Vol. 59, pp. 625-643 {1982}								
FiH.	5	DUPRET et al., "Global Modelling of Heat Transfer in Crystal Growth Furnaces," Int. J. Heat Mass Transfer, Vol. 33, No. 9, pp. 1849-1871 {1990}								
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EXAMINER		hattaki				DATE C	ONSIDE	\sim \sim \sim \sim		
Examiner: In	itial if	citation considered, whether or not ci	tation	is in conf	ormance with	M.P.E.P. 609; draw	line the	rough citation		

Date: December 21, 2005